

E Series Multifunction DAQ – 1.25 MS/s, 12-Bit, 16 or 64 Analog Inputs

NI 607xE

- 1.25 MS/s, 12-bit resolution, up to 64 analog inputs
- Two 12-bit analog outputs (1 MS/s max)
- 8 digital I/O lines (5 V/TTL); two 24-bit counter/timers
- Analog and digital triggering
- Available for PCI, PXI/CompactPCI, IEEE 1394, and ISA
- NI DAQ driver software simplifies configuration and measurements
- 1.25 MS/s stream-to-disk rate

Models

- NI 6070E (MIO-16E-1)
- PCI-MIO-16E-1
- PXI-6070E
- AT-MIO-16E-1
- DAQPad-6070E for IEEE 1394

NI 6071E (MIO-64E-1)

- PCI-6071E
- PXI-6071E

Real-Time

See page 142

NI Application Software

- LabVIEW
- Measurement Studio
- VI Logger

Operating System Compatibility

- Windows 2000/NT/Me/9x*
- Mac OS – not for all hardware
- Windows 2000/Me/98 only for IEEE 1394

Calibration Certificate Included

See page 24

*Visit ni.com/info and enter winxp for the latest operation system information.



Overview

The NI 6070E and NI 6071E data acquisition (DAQ) devices use E Series technology to deliver high performance and reliable data acquisition capabilities to meet a wide range of application requirements. You get up to 1.25 MS/s, 12-bit performance across multiple bus systems, and you choose from either 16 or 64 single-ended analog inputs. Depending on your type of hard drive, these devices can stream to disk at rates up to 1.25 MS/s. These E Series devices feature both analog and digital triggering capability, as well as two 12-bit analog outputs; two 24-bit, 20 MHz counter/timers; and eight digital I/O lines.

DAQPad Configurations

The DAQPad-6070E for IEEE 1394 is available in two different configurations. Both configurations feature 250 V functional isolation from the PC and a low-profile package that fits under your laptop.

The mass termination version features a 68-pin shielded connector to connect signals either from the SCC Series modular signal conditioning products or from our CA-1000 custom-connectivity enclosure.



Figure 1. DAQPad-6070E BNC Termination Version

The BNC termination version features shielded BNC connectors for eight differential-ended analog inputs, two analog outputs, and five auxiliary lines. You access other signals through built-in screw terminal connections. It is ideal for applications where portability and quick connectivity are needed, such as in-vehicle automotive testing or laboratory measurements.

DAQPad-6070E Power

The DAQPad-6070E can be powered by any 9 to 25 VDC power supply, such as a car battery using a cigarette lighter socket. The unit comes with a universal desktop AC-to-DC power supply that can power the DAQPad-6070E from any standard AC power outlet anywhere in the world. You can also use the optional BP-1 rechargeable battery pack to power the DAQPad-6070E for up to 2.5 hours.

See the E Series Multifunction DAQ Overview on page 230 for a detailed hardware overview.

INFO CODES

For more information or to order products online, visit ni.com/info and enter:

pcmio16e1
pxi6070e
atmio16e1
daqpad6070e
pci6071e
pxi6071e

BUY ONLINE!

Family	Bus	Analog Inputs	Resolution	Sampling Rate	Input Range	Analog Outputs	Resolution	Output Rate	Output Range	Digital I/O	Counter/Timers	Triggers
NI 6070E	PCI, PXI/CompactPCI, IEEE 1394, ISA	16 SE/8 DI	12 bits	1.25 MS/s	±0.05 to ±10 V	2	12 bits	1 MS/s	±10 V	8	2, 24-bit	Analog and Digital
NI 6071E	PCI, PXI/CompactPCI,	64 SE/32 DI	12 bits	1.25 MS/s	±0.05 to ±10 V	2	12 bits	1 MS/s	±10 V	8	2, 24-bit	Analog and Digital

Table 1. NI 607xE Channel, Speed, and Resolution Specifications

E Series Multifunction DAQ – 1.25 MS/s, 12-Bit, 16 or 64 Analog Inputs

Figure 2. The DAQPad-6070E fits snugly under laptop PCs for portable applications. By connecting two or more DAQPad-6070E units together with an IEEE 1394 cable, you can use several devices with one PC.



Consider our SCC Series for adding signal and sensor connectivity and signal conditioning to your DAQPad-6070E.

Visit ni.com/sigcon/scc.htm for more information.



Figure 3. Choose the NI BP-1 battery pack to power your DAQPad-6070E for up to 2.5 hours.

See page 233 in the E Series Multifunction DAQ Overview for connector diagrams.

See page 266 for detailed specifications.

Ordering Information

NI 6070E	
PCI-MIO-16E-1	777305-01
PXI-6070E	777060-01
DAQPad-6070E ¹ for IEEE 1394 with	
Mass termination, AC adapter ² , and IEEE 1394 Cable	
U.S. 120 VAC	777867-01
Universal Euro 240 VAC	777867-04
United Kingdom 240 VAC	777867-06
BNC termination, AC adapter ² , and IEEE 1394 cable	
U.S. 120 V	777803-01
Universal Euro 240 VAC	777803-04
United Kingdom 240 VAC	777803-06
AT-MIO-16E-1 ³	777142-01
NI 6071E	
PCI-6071E	777515-01
PXI-6071E	777676-01

Includes NI-DAQ driver software. IEEE 1394 products include 1 m IEEE 1394 cable.

¹Windows 2000/Me/98 only

²The AC adapter is universal. The difference between these kits is the power cable.

³Windows 2000/NT/Me/9x only

Accessories

BP-1 Rechargeable battery pack	
120 VAC charger	776896-01
230 VAC charger	776896-31
DAQPad Accessories	
Rack-mount kit	777665-01
Stacking kit	777666-01
PCI-to-IEEE 1394 adapter	Please call
Cardbus-to-IEEE 1394 adapter	Please call

For information on extended warranty and value-added services, see page 22.

Recommended Configurations

Family	DAQ Device	Accessory	Cable
NI 6070E	PCI-MIO-16E-1	SCB-68 (776844-01)	SH6868-EP (184749-01)
	PXI-6070E	TB-2705 (778241-01)	SH6868-EP (184749-01)
	AT-MIO-16E-1	SCB-68 (776844-01)	SH6868-EP (184749-01)
	DAQPad-6070E (Mass termination)	CA-1000 ⁴ (777664-01)	SH6868-EP (184749-01)
	DAQPad-6070E (BNC termination)	none	none
NI 6071E	PCI-6071E	SCB-100 (776990-01)	SH100100 (182853-01)
	PXI-6071E	Two TBX-68s (777141-01)	SH1006868 (182849-01)

⁴See page 258 for information on CA-1000.

For E Series accessory and cable information, see page 256.

E Series Multifunction DAQ – 1.25 MS/s, 12-Bit, 16 or 64 Analog Inputs

Nominal Range (V)		Absolute Accuracy						Relative Accuracy		
		% of Reading		Offset (mV)	Noise + Quantization (mV)		Temp Drift (%/°C)	Resolution (mV)		
Positive FS	Negative FS	24 Hrs	1 Year		Single Pt.	Averaged		Absolute Accuracy at Full Scale (mV)	Single Pt.	Averaged
10	-10	0.0672	0.0714	6.38	6.10	0.846	0.0010	14.369	7.37	1.11
5	-5	0.0272	0.0314	3.20	3.05	0.423	0.0005	5.193	3.68	0.557
2.5	-2.5	0.0672	0.0714	1.61	1.53	0.211	0.0010	3.605	1.84	0.278
1	-1	0.0672	0.0714	0.653	0.610	0.085	0.0010	1.452	0.737	0.111
0.5	-0.5	0.0672	0.0714	0.335	0.305	0.042	0.0010	0.735	0.368	0.056
0.25	-0.25	0.0672	0.0714	0.176	0.208	0.024	0.0010	0.379	0.238	0.032
0.1	-0.1	0.0672	0.0714	0.081	0.098	0.011	0.0010	0.163	0.111	0.015
0.05	-0.05	0.0672	0.0714	0.049	0.071	0.007	0.0010	0.091	0.082	0.009
10	0	0.0272	0.0314	3.20	3.05	0.423	0.0005	6.765	3.68	0.557
5	0	0.0672	0.0714	1.61	1.53	0.211	0.0010	5.391	1.84	0.278
2	0	0.0672	0.0714	0.653	0.610	0.085	0.0010	2.167	0.737	0.111
1	0	0.0672	0.0714	0.335	0.305	0.042	0.0010	1.092	0.368	0.056
0.5	0	0.0672	0.0714	0.176	0.208	0.024	0.0010	0.558	0.238	0.032
0.2	0	0.0672	0.0714	0.081	0.098	0.011	0.0010	0.235	0.111	0.015
0.1	0	0.0672	0.0714	0.049	0.071	0.007	0.0010	0.127	0.082	0.009

Note: Accuracies are valid for measurements following an internal E Series Calibration. Averaged numbers assume dithering and averaging of 100 single-channel readings. Measurement accuracies are listed for operational temperatures within ±1 °C of internal calibration temperature and ±10 °C of external or factory-calibration temperature. One-year calibration interval recommended. The Absolute Accuracy at Full Scale calculations were performed for a maximum range input voltage (for example, 10 V for the ±10 V range) after one year, assuming 100 pt averaging of data. See page 234 for example calculations.

Table 2. NI 607xE Analog Input Accuracy Specifications.

Nominal Range (V)		Absolute Accuracy					Absolute Accuracy at Full Scale (mV)
		% of Reading			Temp		
Positive FS	Negative FS	24 Hrs	90 Days	1 Year	Offset (µV)	Drift (%/°C)	
10	-10	0.0177	0.0197	0.0219	5.93	0.0005	8.127
10	0	0.0177	0.0197	0.0219	3.49	0.0005	5.685

Note: Temp Drift applies only if ambient is greater than ±10 °C of previous external calibration. (See page 234 for example calculations.)

Table 3. NI 607xE Analog Output Accuracy Specifications.

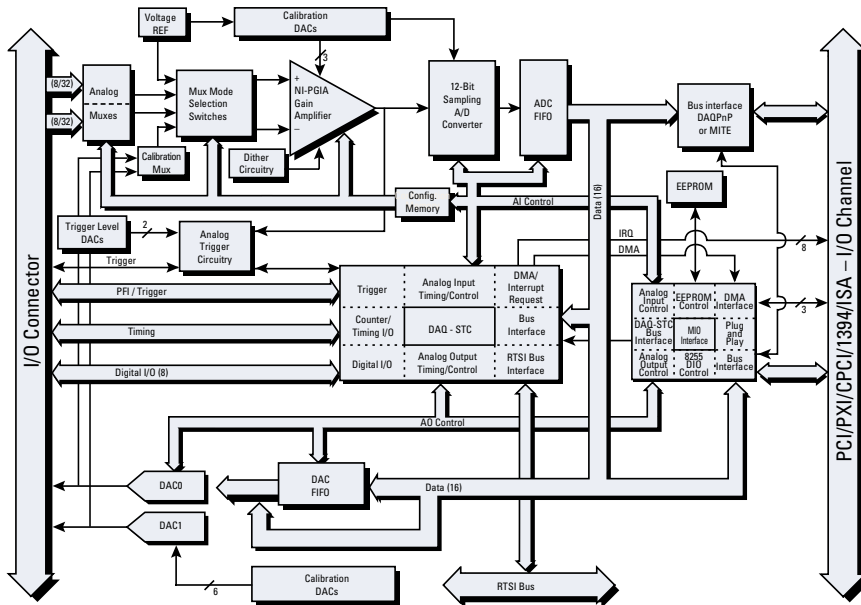


Figure 4. NI 607xE Hardware Block Diagram

E Series Multifunction DAQ Accessories

Selection Guide

Step 1. Select your E Series device.

Step 2. Using Tables 1 and 2 as a guide, determine which accessories are appropriate for that device. Select an accessory. Table 3 provides descriptions for E Series device accessories.

Step 3. Using Tables 1 and 2, determine which cable is required to connect your selected device and accessory.

Device	Accessory			
	TBX-68, CB-68LP, CB-68LPR, DAQ Signal Accessory, CA-1000, BNC-2110, BNC-2120, BNC-2090, SCB-68	TB-2705	SCXI, Signal Conditioning	SCC Modular
	Cables			
68-pin E Series (except DAQCard)	SH68-68-EP (shielded) R6868 (unshielded)	Connects directly to the device (PXI only)	See page 385 for SCXI Signal Conditioning details	See page 461 for SCC Modular Signal Conditioning details
Latching DAQCards NI 6024E, NI 6062E	SHC68-68-EP (shielded) RC68-68 (unshielded)	N/A	See page 385 for SCXI Signal Conditioning details	See page 461 for SCC Modular Signal Conditioning details
Nonlatching DAQCards AI-16E-4, AI-16XE-50	PSHR68-68 (shielded) PR68-68F (unshielded)	N/A	See page 385 for SCXI Signal Conditioning details	See page 461 for SCC Modular Signal Conditioning details

Table 1. Accessories and Cables for 68-Pin and DAQCard E Series Devices

Device	Accessory					
	TBX-68, CB-68LP, CB-68LPR, DAQ Signal Accessory, CA-1000, BNC-2110, BNC-2120, BNC-2090, SCB-68	BNC-2115	TBX-68, CB-68LP CB-68LPR, CA-1000, SCB-68	SCB-100	SCXI Signal Conditioning	SCC Modular Signal Conditioning
	Cables					
100-pin E Series with 64 AI channels NI 6071E, NI 6031E, NI 6033E AT-MIO-64E-3	SH1006868 (shielded); splits into two 68-pin connectors; these accessories are used with the first 68-pin connector. See Figure 16 on page 260.	SH1006868 (shielded); splits into two 68-pin connectors; these accessories are used with the second 68-pin connector.	SH1006868 (shielded); splits into two 68-pin connectors; these accessories are used with the second 68-pin connector.	SH100100 (shielded)	See page 385 for SCXI Signal Conditioning details	See page 461 for SCC Modular Signal Conditioning details
100-pin E Series with 16 AI channels and 32 DIO lines PCI-6025E, AT-6021E	SH1006868 (shielded); splits into two 68-pin connectors; these accessories are used with the first 68-pin connector. See Figure 16 on page 260.	SH1006868 (shielded); splits into two 68-pin connectors; these accessories are used with the second 68-pin connector.	SH1006868 (shielded); splits into two 68-pin connectors; these accessories are used with the second 68-pin connector.	SH100100 (shielded)	See page 385 for SCXI Signal Conditioning details	See page 461 for SCC Modular Signal Conditioning details

Table 2. Accessories and Cables for 100-Pin and DAQCard E Series Devices

Accessory	Description	Page
SCXI Signal Conditioning	High channel-count signal conditioning platform	385
SCC Modular Signal Conditioning	Single or dual channel signal conditioning modules	461
AMUX-64T, 5B, SSR, ER, and SC-204x Signal Conditioning	External signal conditioning accessories	478
BNC-2110	BNC accessory for 68-pin E Series devices	257
BNC-2115	BNC accessory for extended I/O on 100-pin E Series devices	257
BNC-2120	BNC accessory with function generator (for 68-pin E Series devices)	257
BNC-2090	Rack-mountable BNC accessory (for 68-pin E Series devices)	257
CA-1000 enclosure	Configurable connectivity enclosure	257
TB-2705	Latching screw terminal block for PXI E Series modules	258
SCB-100	100-pin, shielded screw terminal block with breadboard areas	258
SCB-68	68-pin, shielded screw terminal block with breadboard areas	258
TBX-68	68-pin, DIN rail-mountable screw terminal block	258
CB-68LP, CB-68LPR	68-pin, low-cost screw terminal block	258
Signal Source and Demo Accessory	DAQ signal accessory to demo and test analog, digital and counter/timer functions	259

For complete and up-to-date information about accessories, visit ni.com/catalog

Table 3. Overview of E Series DAQ Accessories

E Series Multifunction DAQ Accessories

SCXI High-Performance Signal Conditioning (see Figure 1)

SCXI is a modular high-performance signal conditioning platform that you use as a front end to your E Series DAQ device. With the SCXI multiplexing architecture, you can expand your analog inputs to 3,072 channels. Additionally, SCXI offers a variety of modules for connecting to thermocouples, RTDs, strain gauge transducers, LVDT position sensors, ICP-compatible accelerometers/microphones, thermistors, millivolt inputs, voltage inputs up to 1000 V, current inputs (0-20mA), frequency inputs or dynamic signals.

See page 385 for details on SCXI Signal Conditioning.

SCC Series – Modular Signal Conditioning for Low-Channel Count Applications (see Figure 2)

The SCC Series modular signal conditioning system consists of SCC modules that plug into a low-profile SC-2345 shielded carrier. SCC modules give you single or dual-channel signal conditioning for up to 16 analog input channels and eight digital I/O lines of your plug-in E Series DAQ device. The SCC Series offers signal conditioning for a variety of inputs, including thermocouples, RTDs, strain gauges, ICP-compatible accelerometers, accelerators, analog inputs requiring isolation, high voltage (up to 100 V), current (0-20mA), and optically isolated digital I/O. Lowpass filtering and bread boarding modules are also available.

See page 461 for details on SCC Signal Conditioning.

Connector Blocks

BNC-2100 Series Connector Blocks (see Figure 3)

Shielded connector blocks with signal-labeled BNC connectors for easy connectivity of your analog input, analog output, digital I/O and counter/timer signals to your E Series device. The BNC-2110 and BNC-2120 work with all E Series devices. The BNC-2120 also provides a function generator, quadrature encoder, temperature reference, thermocouple connector and LED so that you can test the functionality of your hardware. The BNC-2115 has 24 BNC inputs for connecting to the extended I/O channels of our 100-pin E Series DAQ devices.

BNC-2110.....	777643-01
Dimensions – 20.3 by 11.2 by 5.5 cm (8.0 by 4.4 by 2.2 in.)	
BNC-2115.....	777807-01
Dimensions – 20.3 by 11.2 by 5.5 cm (8.0 by 4.4 by 2.2 in.)	
BNC-2120.....	777960-01
Dimensions – 26.7 by 11.2 by 6.0 cm (10.5 by 4.4 by 2.4 in.)	

BNC-2090 Shielded BNC Adapter Chassis (see Figure 4)

Shielded, rack-mountable adapter with signal-labeled BNC connectors, spring terminal blocks, and component locations for passive signal conditioning. Consists of 22 BNC connectors and 28 spring terminals to simplify connection to your analog, digital, trigger and counter/timer signals. The BNC-2090 has silk-screened component locations that you use to develop simple signal conditioning circuits. For added flexibility, you can connect any E Series DAQ device to the BNC-2090 from the front or rear through dual 68-pin connectors.

BNC-2090	777270-01
Dimensions – 48.3 by 4.4 by 18.8 cm (19.0 by 1.7 by 7.4 in.)	



Figure 1. SCXI High-Performance Signal Conditioning



Figure 2. SCC Portable, Modular Signal Conditioning



Figure 3. BNC-2100 Series Connector Blocks



Figure 4. BNC-2090 Shielded BNC Adapter Chassis



Figure 5. CA-1000 Configurable Signal Conditioning Enclosure

E Series Multifunction DAQ Accessories



Figure 6. TB-2705 Terminal Block

CA-1000 Configurable Signal Conditioning Enclosure (see Figure 5)

Configurable enclosure that gives you maximum user-defined connectivity and flexibility through customized panelettes. Each enclosure can accommodate up to 9 panelettes.

Dimensions – 30.7 by 25.4 by 4.3 cm (21.1 by 10 by 1.7 in.)

See page 263 for more information about the CA-1000.



Figure 7. SCB-68 and SCB-100 Shielded I/O Connector Blocks

TB-2705 Terminal Block for 68-pin PXI E Series Devices (see Figure 6)

Screw terminal block for PXI that works with your PXI E Series DAQ devices. Latches to the front of your PXI module with locking screws and provides strain relief as well as easy access to your analog, digital, trigger and counter/timer signals through screw terminals.

TB-2705778241-01

Dimensions – 8.43 by 10.41 by 2.03 cm (3.32 by 4.1 by 0.8 in.)

SCB-68 and SCB-100 Shielded I/O Connector Blocks (see Figure 7)

Shielded I/O connector blocks for rugged, very low-noise signal termination for connecting to 68-pin or 100-pin E Series DAQ devices, respectively. Silk-screened component locations for easy addition of simple signal-conditioning circuitry for your analog input channels. They also include general-purpose breadboard areas (two on the SCB-68; three on the SCB-100) as well as an IC temperature sensor for cold-junction compensation in temperature measurements.

SCB-68776844-01

Dimensions – 19.5 by 15.2 by 4.5 cm (7.7 by 6.0 by 1.8 in.)

SCB-100776990-01

Dimensions – 19.5 by 15.2 by 4.5 cm (7.7 by 6.0 by 1.8 in.)

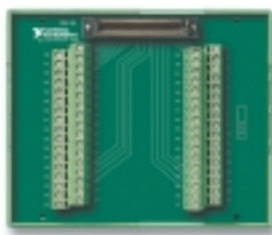


Figure 8. TBX-68 I/O Connector Block

TBX-68 I/O Connector Block with DIN-Rail Mounting (see Figure 8)

Termination accessory with 68 screw terminals for easy connection of field I/O signals to 68-pin DAQ devices. Includes one 68-pin male connector for direct connection to 68-pin cables. The TBX-68 is mounted in a protective plastic base with hardware for mounting on a standard DIN rail.

TBX-68777141-01

Dimensions – 12.50 by 10.74 cm (4.92 by 4.23 in.)

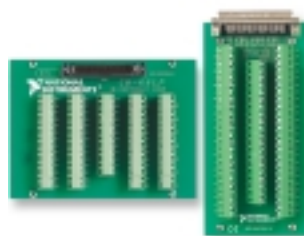


Figure 9. CB-68LP and CB-68LPR I/O Connector Blocks

CB-68LP and CB-68LPR I/O Connector Blocks (see Figure 9)

Low-cost termination accessory with 68 screw terminals for easy connection of field I/O signals to 68-pin E Series DAQ devices. Includes one 68-pin male connector for direct connection to 68-pin cables. The connector blocks include standoffs for use on a desktop or for mounting in a custom panel. The CB-68LP has a vertical-mounted 68-pin connector. The CB-68LPR has a right-angle mounted connector, and is used with the CA-1000 (see page 263).

CB-68LP777145-01

Dimensions – 14.35 by 10.74 cm (5.65 by 4.23 in.)

CB-68LPR777145-02

Dimensions – 7.62 by 16.19 cm (3.00 by 6.36 in.)



Figure 10. DAQ Signal Accessory

E Series Multifunction DAQ Accessories and Cables

Signal Source and Demo Accessory (see Figure 10)

The DAQ Signal Accessory demonstrates and tests the use of analog, digital, and counter/timer functions of DAQ devices. You can connect the DAQ Signal Accessory directly to your DAQ device. It features a built-in function generator, quadrature encoder, solid-state relay, IC temperature sensor, noise generator, microphone jack, thermocouple jack, four LEDs, and a digital trigger button. The DAQ Signal Accessory works with all E Series DAQ devices.

DAQ Signal Accessory.....777382-01
 Dimensions – 12.7 by 12.7 cm (5.0 by 5.0 in.)

RTSI Bus Cables (see Figures 11 and 12)

Use RTSI bus cables to connect timing and synchronization signals among Measurement, Vision, Motion, and Controller Area Network (CAN) boards for PCI and ISA and DAQPad 6070E boards. For systems using long and short boards order the extended RTSI cable.

2 boards776249-02
 3 boards776249-03
 4 boards776249-04
 5 boards776249-05
 Extended, 5 boards777562-05
 3 external boards186464-01

Shielded I/O Cables

SH68-68-EP Shielded Cable (see Figure 13)

Shielded 68-conductor cable terminated with two 68-pin female 0.050 series D-type connectors. Features individually-shielded analog twisted pairs for reduced crosstalk with high-speed devices. This cable works with all 68-pin E Series devices (except latching DAQCards). If you need a right-angle connector, the SH68-68R1-EP shielded cable is fully compatible.

1 m.....184749-01
 2 m.....184749-02

SH68-68R1-EP Shielded Cable (see Figure 14)

Shielded 68-conductor cable; one end terminates with a 68-pin female 0.050 series D-type connector and the other end terminates with a right-angle 68-pin female 0.050 series D-type connector.

1 m.....187051-01

SH100100 Shielded Cable (see Figure 15)

Shielded 100-conductor cable terminated with 100-pin male 0.050 series D-type connectors. This cable connects the 100-pin E Series devices to 100-pin accessories.

1 m.....182853-01
 2 m.....182853-02

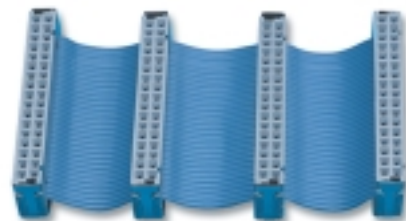


Figure 11. RTSI Bus Cable



Figure 12. Extended RTSI Bus Cable



Figure 13. SH68-68-EP Shielded Cable



Figure 14. SH68-68R1-EP Shielded Cable



Figure 15. SH100100 Shielded Cable

E Series Multifunction DAQ Accessories and Cables



Figure 16. SH1006868 Shielded Cable



Figure 17. SHC68-68-EP Shielded Cable



Figure 18. PSHR68-68 Shielded Cable Kit



Figure 19. PSHR68-68M Shielded Cable



Figure 20. R6868 Ribbon Cable

SH1006868 Shielded Cable (see Figure 16)

Shielded cable that connects to 100-pin E Series devices and terminates with two female 68-pin 0.050 series D-type connectors. See Table 2 on page 256 for accessories compatible with each 68-pin connector.

1 m	182849-01
2 m	182849-02

SHC68-68-EP and SHC68U-68-EP Shielded Cables for Latching E Series DAQCards (see Figure 17)

These cables connect a latching E Series DAQCard (NI 6062E and NI 6024E) to standard 68-pin accessories. Latching screws secure the shielded connector to the PCMCIA DAQCard. The SHC68-68-EP is a shielded 68-conductor cable terminated with a VHDCl 68-pin male connector at one end and a 68-pin female 0.050 series D-type connector at the other. The SHC68U-68-EP is identical to the SHC68-68-EP except it uses an inverted VHDCl 68-pin male connector. Use the SH68U-68-EP for a DAQCard located in the bottom PCMCIA slot in your laptop. Use the SHC68-68-EP cable with a DAQCard inserted in the upper PCMCIA slot in your laptop. When using two E Series DAQCard PCMCIA devices in adjacent slots, you must use one SHC68-68-EP and one SHC68U-68-EP.

SHC68-68-EP

0.5 m	186838-0R5
1 m	186838-01

SHC68U-68-EP

0.5 m	187406-0R5
1 m	187406-01

PSHR68-68 Shielded Cable Kit for Nonlatching DAQCards (see Figure 18)

Shielded cable for use in connecting non-latching E Series DAQCards (AI-16E-4 and AI-16XE-50) with 68-pin accessories. The kit contains the PSHR68-68M, the PCMCIA Strain-Relief Adapter and a 1 m SH68-68-EP cable.

1 m	777293-01
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PSHR68-68M Shielded Cable for Nonlatching DAQCards (see Figure 19)

Shielded cable for use in connecting non-latching E Series DAQCards (AI-16E-4 and AI-16XE-50) with custom cables and other 68-pin cable assemblies.

0.1 m	183569-01
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E Series Multifunction DAQ Accessories and Cables

Ribbon I/O Cables

RC688 Ribbon Cable for E Series Devices (see Figure 20)

68-conductor flat ribbon cable terminated with two 68-pin connectors. Use this cable to connect a 68-pin E Series device to 68-pin accessories.

1 m182482-01

RC68-68 Ribbon Cable for Latching DAQCards (see Figure 21)

Ribbon cable that connects to a latching E Series DAQCard (NI 6062E, NI 6024E) and is terminated with a 68-pin female connector that attaches directly to 68-pin accessories. Two RC68-68 cables can be used together in adjacent PCMCIA slots.

0.25 m187252-0R25

1 m187252-01

PR68-68F for Non-Latching DAQCards (see Figure 22)

Ribbon cable that connects to a non-latching E Series DAQCard (AI-16E-4, AI-16XE-50) and is terminated with a 68-pin female connector that attaches directly to 68-pin accessories.

0.2 m183646-0R2

1 m183646-01

Custom Connectivity Components

68-Pin Custom Cable Connector/Backshell Kit (see Figure 23)

68-pin female mating connector and backshell kit for use in making custom cables. Solder-cup contacts are available for soldering of cable wires to the connector.

68-pin connector/backshell kit776832-01

PCB Mounting Connectors for Custom Accessories (see Figure 24)

PCB connectors for use in building custom accessories that connect to 68-conductor or 100-conductor shielded and ribbon cables. Two connectors are available, one for right-angle and one for vertical mounting onto a PCB.

68-position, male, right-angle mounting777600-01

68-position, male, vertical mounting777601-01

100-position, female, right-angle mounting777778-01

100-position, female, vertical mounting.....777779-01

PCMCIA Strain-Relief Accessory (see Figure 25)

Accessory that attaches to the bottom of your notebook computer and provides adjustable strain relief for one or two PCMCIA cables attached to the installed PCMCIA card(s). Used with non-latching E Series DAQCards (AI-16E-4, AI-16XE-50).

PCMCIA Strain-Relief Accessory777550-01



Figure 21. RC68-68 Ribbon Cable



Figure 22. PR68-68F Ribbon Cable

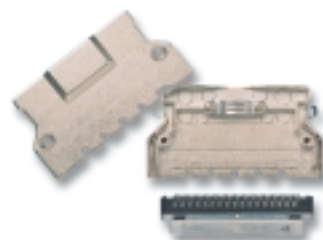


Figure 23. 68-Pin Custom Cable Connector/Backshell Kit

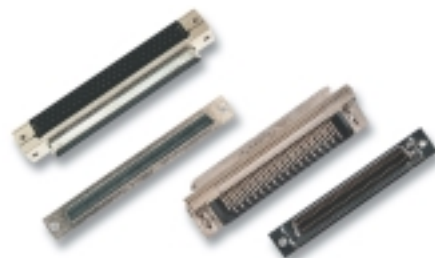


Figure 24. PCB Mounting Connectors for Custom Accessories



Figure 25. PCMCIA Strain-Relief Accessory

E Series Multifunction DAQ Accessories and Cables



Figure 26. USB Cable



Figure 27. IEEE 1394 Cable

USB Cable (see Figure 26)

Cable that connects DAQPad devices for the Universal Serial Bus (USB) to a USB port. The USB cables have a USB B-type connector and a USB A-type connector.

1 m	184125-01
2 m	184125-02

IEEE 1394 Cable (see Figure 27)

Cable that connects DAQPad devices for IEEE 1394 (FireWire) to an IEEE 1394 port.

1 m (latching)	185798-01
2 m (latching)	185798-02

Use Interactive Online Catalog Configurator for Quick Product Selection

You can now easily configure NI multifunction data acquisition (DAQ) measurement systems using a new, interactive feature of our online catalog. The interactive online catalog offers a better, easier way to select and purchase measurement solutions from National Instruments. Based on user input, the interactive online catalog suggests products and then suggests the appropriate cables and accessories for those products. This new automated tool helps eliminate ordering mistakes and product-compatibility errors.

To take advantage of the online catalog for multifunction DAQ devices, visit ni.com/catalog

From the Products and Services menu, select Data Acquisition, then select Multifunction I/O. The online catalog prompts you with a series of questions regarding preferences for operating system, computer bus, number of channels, and maximum sampling rate. The online catalog then recommends several appropriate DAQ devices. You can review specifications on each device and select your preferred product. Next, the catalog suggests the preferred accessory and cable solution designed to work with the selected DAQ device. You have the option of choosing the preferred configuration or choosing from a separate list of accessories and cables that also work with the selected DAQ device. You can purchase the selected items online.



Figure 28. Use the interactive configuration tool in the NI online catalog to select and purchase multifunction DAQ solutions.

Configurable Signal Conditioning Enclosure

CA-1000

- Versatile connector/enclosure system
- Houses signal conditioning and connector block accessories
- Wide variety of I/O connectivity and panelette options
- Holds maximum of 18 connectivity/interface panelettes
- Low profile enclosure
- Rack-mount and stacking kits available

I/O Connectivity

- BNC
- Thermocouple
- Banana jack
- LEMO® connector (B-Series)
- MIL-Spec
- SMB
- Dual 9-pin D-Sub
- Strain relief

Interface Panelettes

- Momentary pushbutton switch
- Potentiometer
- Toggle switch
- Rocker switch
- LED



Overview

The National Instruments CA-1000 is a configurable signal conditioning enclosure designed for maximum user-defined I/O connectivity and flexibility. The CA-1000 is a portable enclosure for laptop, desktop, and rack-mount applications. In the CA-1000, you can install many NI signal conditioning accessories, such as the SC-204x signal conditioning products, and the SCB-68, CB-68LPR, and CB-50LP terminal blocks. The result is a compact, portable, flexible, and comprehensive signal conditioning/interconnection system. The CA-1000 also facilitates quick connection and disconnection with standard I/O connectors for easy system integration and reconfiguration. By adding interface panelettes, such as toggle switches, potentiometers, and LEDs, you can locally control and verify system operation.

Description

The CA-1000 system includes four components: 1) CA-1000 enclosure, 2) I/O and interface panelettes, 3) signal conditioning or measurement accessories installed in the CA-1000, and 4) for 50-pin accessories, an internal cable adapter to connect the signal conditioning accessory to the cable attached to the CA-1000.

CA-1000 Enclosure

The metal enclosure provides a low-profile, portable housing for signal conditioning and connector accessories. You can place the enclosure under a laptop PC, on a benchtop, or in a 19 in. rack. You can also stack two or more enclosures with the stacking kit. The CA-1000 enclosure includes five cable entry locations, so you can place the 68-pin or 50-pin connector that you cable to your measurement device on either the side or the rear of the CA-1000

enclosure. Please note, the CA-1000 is shipped without any panelettes, signal conditioning accessories, connector blocks, or cables. Order all of these components separately.

Internal Accessories

The CA-1000 houses a variety of signal conditioning and data acquisition accessories, including the SC-204x, SCB-68, CB-68LPR, and CB-50LP (Table 1 on page 264). You mount these accessories to the bottom panel of the CA-1000 enclosure.

I/O Panelettes

The CA-1000 includes a user-configurable signal connection scheme. This connectivity flexibility is achieved with interchangeable panelettes. The panelettes, which come with standard signal connectors – for example, BNC, SMB, banana jack, thermocouple plugs, and LEMO, MIL-Spec, and 9-pin D-Sub connectors – mount in the front of the CA-1000 enclosure. The CA-1000 front panel offers nine panelette slots. The rear panel can also be removed offering nine more panelette slots. However, this option is not available if you are using the SCB-68 inside the CA-1000. You can mix and match different types of panelettes. Each panelette (except for the strain-relief panel) includes lead wires that you connect to the screw terminals of the accessory mounted inside the CA-1000. You can therefore connect the panelettes to any I/O signal available on the accessory.

INFO CODES

For more information or to order products online, visit ni.com/info and enter:

ca1000

BUY ONLINE!

Configurable Signal Conditioning Enclosure

Interface Panelettes

National Instruments also offers interface panelettes, which expand the functionality of the CA-1000. Interface panelettes include traditional interface controls and displays, such as rocker switches, toggle switches, momentary switches, potentiometers, and LEDs. Using interface panelettes, which are mounted alongside I/O panelettes, you can change hardware inputs, trigger events, or verify operational status. Each interface panelette includes lead wires for connection to the screw terminals of the accessory mounted inside the CA-1000.

Cabling

The cabling needed to connect the CA-1000 to the measurement device depends on the accessories installed in the CA-1000 and the

measurement device used. Some accessories installed in the CA-1000 require internal cabling to connect the accessory to the CA-1000 wall. Use Table 1 to determine what cabling components you need, including the cable to your measurement device.

The CA-1000 also provides the flexibility of five external interconnection locations, giving convenient cabling for laptop applications by aligning the I/O connector with the location of the PCMCIA slots on laptop computers. With the five external interconnection locations, you can also customize desktop and rack-mount applications for added convenience.

Device	Connector Blocks		
	SC-204x Series	CB-50LP	CB-68LPR or SCB-68
68-pin E Series DAQ Devices (except DAQCards)	R68M-50F and SH68-68-EP ¹	N/A	SH68-68-EP ¹
100-pin E Series DAQ Devices ³	Applicable for one leg	N/A	SH1006868
Latching E Series DAQCards:	R68M-50F and SHC68-68-EP	N/A	SHC68-68-EP
DAQCard-6062E, DAQCard-6024E	–	–	–
Nonlatching E Series DAQCards:	R68M-50F and PSHR68-68 Shielded Cable Kit ²	N/A	PSHR68-68 Shielded Cable Kit ²
DAQCard-AI-16E-4, DAQCard-AI-16XE-50	–	–	–
68-pin Digital I/O and Counter/Timer Devices (except DAQCards)	N/A	N/A	SH68-68-D1
PCI-DIO-32HS, PXI-6533, AT-DIO-32HS,	–	–	–
NI 6534, NI 660x	–	–	–
Nonlatching 68-pin Digital I/O DAQCards:	N/A	N/A	PSHR68-68-D1 Shielded Cable Kit
DAQCard-6533	–	–	–
Simultaneous Sampling Multifunction DAQ Devices	N/A	N/A	SH68-68-EP ¹
PCI-6503	N/A	R50M-50F and SH50-50	N/A
PC-DIO-24	–	–	–
DAQCard-DIO-24	N/A	R50M-50F and PSH27-50F-D1	N/A
NI 6527 ³ , PCI-DIO-96 ³ , PXI-6508 ³ , DAQPad-6508 ³	N/A	Two R50M-50F and R1005050 ⁴	N/A
PC-DIO-96 ³	N/A	Two R50M-50F and NB5 ⁴	N/A

¹You can also use the SH68-68R1-EP or R6868. ²You can also use the PR68-68F. ³You can use two CA-1000 enclosures with one of these devices. Please note: If you are using a NI 435x series data logger, please see Figure 1 on page 298 for information on cabling to a CB-68T and CA-1000. ⁴Splits into two 50-pin connectors. See page 319 for information on using the CA-1000 with signal source products.

Table 1. CA-1000 Cabling



Table 2. CA-1000 Panelette Options

Configurable Signal Conditioning Enclosure

Panelette	Description	Connectors/Units per Panelette	Slot Width
Minithermocouple Jack	J-type	2	1
	K-type	2	1
	Uncompensated	2	1
Thermocouple Jack	J-type	1	1
	K-type	1	1
	Uncompensated	1	1
BNC	BNC connector	2	1
SMB	SMB connector	4	1
Banana Jack	Banana Jack	2	1
LEMO	2-pin female	2	1
	4, 6-pin female	1	1
MIL-Spec	2, 4, 6-pin female	1	1
9-pin D-sub	Single (male)	1	2
	Single (female)	1	2
	Dual (male)	2	3
	Dual (female)	2	3
Momentary Pushbutton Switch	On – off	2	1
Toggle Switch	(On – off – on)	2	1
Rocker Switch	(On – off – on)	1	1
LED	A red, green, yellow, and orange LED	4	1
Potentiometer	1 turn, 10 kW	1	1
Strain Relief	Screw clamp	1	2
Blank	Filler panel	–	1

Table 3. CA-1000 Panelette descriptions

Ordering Information

CA-1000 (enclosure only)777664-01
 Dimensions – 30.7 by 25.4 by 4.3 cm (21.1 by 10.3 by 1.7 in.)

I/O Connector Panelettes

Minithermocouple, J-type (2 included)184736-01
 Minithermocouple, K-type (2 included)184736-02
 Minithermocouple, uncompensated (2 included)184736-03
 Thermocouple, J-type187597-01
 Thermocouple, K-type187597-02
 Thermocouple, uncompensated187597-03
 BNC (2 included)184737-01
 Banana jack (2 included)186405-01
 LEMO connector (B-Series)
 Dual 2-pin, female187585-01
 4-pin, female187585-02
 6-pin, female187585-03
 MIL-C-26482 (Series 1)
 MS3112E8-2 S.....187591-01
 MS3112E8-4 S.....187591-02
 MS3112E10-6 S.....187591-03
 SMB (4 included)185505-01

Ordering Information (continued)

Strain relief.....184721-01
 9-Pin D-Sub
 Single male.....184738-01
 Dual male.....184738-02
 Single female.....184738-03
 Dual female.....184738-04
 Blank184483-01

Interface Panelettes

Momentary pushbutton switch (2 included)185380-01
 Rocker switch (on/off/on).....185379-01
 Toggle switch (on/off/on – 2 included)185378-01
 Potentiometer (10 k Ω , single turn)185377-01
 LED 4 – (Includes: 1 green,
 1 red, 1 orange, 1 yellow)185376-01

External Cables

SH68-68-EP, 1 m182419-01
 SH68-68-D1, 1 m.....183432-01
 SH68-68R1-EP, 1 m187051-01
 SH50-50, 1 m777720-01
 R6868, 1 m182482-01
 R1005050, 1 m182762-01
 NB5, 1 m181304-10
 SH1006868, 1 m182849-01
 PSHR68-68 Shielded Cable Kit777293-01
 PSHR68-68-D1 Shielded Cable Kit777420-01
 PR68-68F, 1 m183646-01
 PSH27-50F-D1, 1 m.....776989-01
 SHC68-68-EP, 1 m186838-01

Internal Cables

R50M-50F ribbon cable.....184526-0R3
 R68M-50F MIO bulkhead ribbon cable.....777660-0R3

Accessories

CA-1000 Rack-Mount Kit (1U)777665-01
 CA-1000 Stacking Kit.....777666-01
 CA-1000 Panel Mount Kit187243-01
 Strain Relief Kit¹.....187407-01
¹You cannot use the Strain Relief Kit in conjunction with the rack-mount, panel-mount, or stacking kits.

For information on extended warranty and value added services, see page 22.

E Series Multifunction DAQ Overview

Self-Calibration Using an Internal Reference

The E Series analog inputs and outputs have calibration circuitry to correct gain and offset errors. You can calibrate the device in software to avoid analog I/O errors caused by time and temperature drift at run time. No external circuitry is necessary; an internal reference ensures high accuracy and stability over time and temperature. Factory-calibration constants are permanently stored in an onboard EEPROM and cannot be modified. A modifiable section of the EEPROM stores user-modifiable constants. You can return the devices to their initial factory calibration by accessing the unmodified factory constants. Included with all E Series devices is an NIST-traceable and ISO-9002 certified calibration certificate. Visit ni.com/calibration for more information.

I/O Interface – MITE and DAQ-PnP

All of the PCI and PXI E Series use the MITE ASIC as a bus master interface to the PCI bus. The E Series products for ISA use an ASIC that fully implements the Plug and Play ISA Specification, so that the DMA level, interrupt channels, and base I/O address are all software configurable. All other E Series devices are inherently Plug and Play compatible. Visit ni.com/info and enter *exniev* to download a technical paper on bus mastering.

RTSI Bus Interface

All E Series devices except DAQCards, USB DAQ Pads, and PXI modules are interfaced to the National Instruments RTSI bus with an embedded cross-matrix switch in the DAQ-STC. This switch synchronizes several DAQ devices by sending timing signals to them on the RTSI bus. Using RTSI bus, a single master device can control one or more slave devices for both single and multiple A/D conversions. The PXI Trigger bus serves the same purpose for PXI systems as RTSI bus.

E Series Multifunction DAQ Software NI-DAQ

NI-DAQ, our driver software bundled with every E Series multifunction DAQ device, provides access to the features of your DAQ hardware, so that you can easily develop powerful measurement solutions.

You can use NI-DAQ to perform single-point and buffered analog I/O, digital I/O, and counter/timer input operations. You can perform those operations individually, or program your device to perform multiple operations simultaneously. To facilitate integration of signal conditioning in your system, NI-DAQ provides you with a single interface for programming both the E Series device and signal conditioning modules. Using NI-DAQ, you can also synchronize your E Series multifunction DAQ device with other measurement devices, to build measurement systems customized to your particular needs.

Measurement & Automation Explorer

NI Measurement & Automation Explorer (MAX) software, which is

bundled with every E Series multifunction DAQ device, guides you through hardware configuration, channel scaling, and sensor set-up. You can also test the basic operation of your E Series device and signal connections using a test panel.

What About Signal Conditioning?

Signal conditioning is one of the most important, and most overlooked, components of a data acquisition system. Many sensors require special signal conditioning technology, and no DAQ device has the capability to provide all types of signal conditioning to all sensors. Using NI signal conditioning products, you can measure a wide variety of signals and sensors. These modular conditioning devices come in a range of sizes, from rack-mountable SCXI systems to portable SCC systems.

See page 383 for more information on Signal Conditioning.

ACH8	34	68	ACH0
ACH1	33	67	AIGND
AIGND	32	66	ACH9
ACH10	31	65	ACH2
ACH3	30	64	AIGND
AIGND	29	63	ACH11
ACH4	28	62	AISENSE
AIGND	27	61	ACH12
ACH13	26	60	ACH5
ACH6	25	59	AIGND
AIGND	24	58	ACH14
ACH15	23	57	ACH7
DAC0OUT [†]	22	56	AIGND
DAC1OUT [†]	21	55	ADGND ¹
EXTREF [†]	20	54	ADGND ¹
DIO4	19	53	DGND
DIO1	17	51	DIO5
DIO6	16	50	DGND
DGND	15	49	DIO2
+5 V	14	48	DIO7
DGND	13	47	DIO3
DGND	12	46	SCANCLK
PF10/TRIG1	11	45	EXTSTROBE*
PF11/TRIG2	10	44	DGND
DGND	9	43	PF2/CONVERT*
+5 V	8	42	PF3/GPCTR1_SOURCE
DGND	7	41	PF4/GPCTR1_GATE
PF15/UPDATE*	6	40	GPCTR1_OUT
PF16/WFTRIG	5	39	DGND
DGND	4	38	PF7/STARTSCAN
PF13/GPCTR0_GATE	3	37	PF8/GPCTR0_SOURCE
GPCTR0_OUT	2	36	DGND
FREQ_OUT	1	35	DGND

[†] Not available on AT-AI-16XE-10, PCI-6032E, DAQCard-AI-16E-4, DAQCard-AI-16XE-50

Figure 3. 68-Pin I/O Connector for NI 6070E, NI 6060E, NI 6062E, NI 6052E, NI 6041E, NI 6040E, NI 6036E, NI 6035E, NI 6034E, NI 6032E, NI 6030E, NI 6024E, NI 6023E, NI 6020E, NI 6012E and NI 6011E Devices

AIGND	1	51	ACH16
AIGND	2	52	ACH24
ACH0	3	53	ACH17
ACH8	4	54	ACH25
ACH1	5	55	ACH18
ACH9	6	56	ACH26
ACH2	7	57	ACH19
ACH10	8	58	ACH27
ACH3	9	59	ACH20
ACH11	10	60	ACH28
ACH4	11	61	ACH21
ACH12	12	62	ACH29
ACH5	13	63	ACH22
ACH13	14	64	ACH30
ACH6	15	65	ACH23
ACH14	16	66	ACH31
ACH7	17	67	ACH32
ACH15	18	68	ACH40
AISENSE	19	69	ACH33
DAC0OUT [†]	20	70	ACH41
DAC1OUT [†]	21	71	ACH34
EXTREF [†]	22	72	ACH42
ADGND ¹	23	73	ACH35
DGND	24	74	ACH37
DIO0	25	75	ACH38
DIO4	26	76	AIGND
DIO1	27	77	ACH36
DIO5	28	78	ACH44
DIO2	29	79	ACH37
DIO6	30	80	ACH45
DIO3	31	81	ACH38
DIO7	32	82	ACH46
DGND	33	83	ACH39
+5 V	34	84	ACH47
+5 V	35	85	ACH48
SCANCLK	36	86	ACH56
EXTSTROBE*	37	87	ACH49
PF10/TRIG1	38	88	ACH57
PF11/TRIG2	39	89	ACH50
PF12/CONVERT*	40	90	ACH58
PF13/GPCTR1_SOURCE	41	91	ACH51
PF14/GPCTR1_GATE	42	92	ACH59
GPCTR1_OUT	43	93	ACH52
PF15/UPDATE*	44	94	ACH60
PF16/WFTRIG	45	95	ACH53
PF17/STARTSCAN	46	96	ACH61
PF18/GPCTR0_SOURCE	47	97	ACH54
PF19/GPCTR0_GATE	48	98	ACH62
GPCTR0_OUT	49	99	ACH55
FREQ_OUT	50	100	ACH63

[†] Not available on PCI-6033E

Figure 2. 100-Pin I/O Connector for NI 6071E, NI 6061E, NI 6031E, NI 6033E Devices

AIGND	1	51	PC7
AIGND	2	52	GND
ACH0	3	53	PC6
ACH8	4	54	GND
ACH1	5	55	PC5
ACH9	6	56	GND
ACH2	7	57	PC4
ACH10	8	58	GND
ACH3	9	59	PC3
ACH11	10	60	GND
ACH4	11	61	PC2
ACH12	12	62	GND
ACH5	13	63	PC1
ACH13	14	64	GND
ACH6	15	65	PC0
ACH14	16	66	GND
ACH7	17	67	PB7
ACH15	18	68	GND
AISENSE	19	69	PB6
DAC0OUT [†]	20	70	GND
DAC1OUT [†]	21	71	PB5
RESERVED	22	72	GND
ADGND	23	73	PB4
DGND	24	74	GND
DIO4	25	75	PB3
DIO1	26	76	GND
DIO5	27	77	PB2
DIO2	28	78	GND
DIO6	29	79	PB1
DIO3	30	80	PC2
DIO7	31	81	PB0
DGND	32	82	GND
DGND	33	83	PA7
+5 V	34	84	GND
+5 V	35	85	PA6
SCANCLK	36	86	GND
EXTSTROBE*	37	87	PA5
PF10/TRIG1	38	88	GND
PF11/TRIG2	39	89	PA4
PF12/CONVERT*	40	90	GND
PF13/GPCTR1_SOURCE	41	91	PA3
PF14/GPCTR1_GATE	42	92	GND
GPCTR1_OUT	43	93	PA2
PF15/UPDATE*	44	94	GND
PF16/WFTRIG	45	95	PA1
PF17/STARTSCAN	46	96	GND
GPCTR0_SOURCE	47	97	PA0
GPCTR0_GATE	48	98	GND
GPCTR0_OUT	49	99	+5 V
FREQ_OUT	50	100	GND

Figure 4. 100-Pin I/O Connector for NI 6021E and NI 6025E Devices

E Series Multifunction DAQ Specifications

Specifications – 12-Bit E Series (NI 607xE, NI 606xE, NI 604xE, NI 602xE)

These specifications are typical for 25 °C unless otherwise noted.

Analog Input

Accuracy specifications See tables in E Series Product pages.

Input Characteristics

Number of channels

6070E 6060E 6062E 604xE 602xE	16 single-ended or 8 differential (software selectable per channel)
6071E 6061E	64 single-ended or 32 differential (software selectable per channel)

Type of ADC..... Successive approximation

Resolution 12 bits, 1 in 4,096

Maximum sampling rate

607xE	1.25 MS/s
6060E, 6062E	500 kS/s
604xE	500 kS/s single-channel scanning 250 kS/s multichannel scanning
6061E	500 kS/s single-channel scanning 333 kS/s multichannel
6023E 6024E 6025E	200 kS/s
6020E 6021E	100 kS/s

Streaming-to-disk rate (system dependent)¹

607xE	1.25 MS/s
606xE	500 kS/s
604xE	250 kS/s
6023E 6024E 6025E	200 kS/s
6020E 6021E	100 kS/s ²

¹Streaming-to-disk rates do not apply to RT Series devices.

²DAQPad-6020E rates with SCSI or DMA-enabled EIDE

Input signal ranges

Device	Range (Software Selectable)	Input Range	
		Bipolar	Unipolar
607xE	20 V	±10 V	–
606xE	10 V	±5 V	0 to 10 V
604xE	5 V	±2.5 V	0 to 5 V
6020E	2 V	±1 V	0 to 2 V
6021E	1 V	±500 mV	0 to 1 V
	500 mV	±250 mV	0 to 500 mV
	200 mV	±100 mV	0 to 200 mV
	100 mV	±50 mV	0 to 100 mV
6023E	20 V	±10 V	–
6024E	10 V	±5 V	–
6025E	1 V	±500 mV	–
	100 mV	±50 mV	–

Input coupling DC

Maximum working voltage

(signal + common mode) Input should remain within
±11 V of ground

Overvoltage protection

Device	Powered On	Powered Off
607xE 606xE 604xE	±25 V	±15 V
6023E 6024E 6025E	±40 V	±25 V
6020E 6021E	±35 V	±25 V

Inputs protected

6070E, 6060E 6062E, 604xE 602xE	ACH-0.15>, AISENSE
6071E, 6061E	ACH-0.63>, AISENSE, AISENSE2

FIFO buffer size

AT-MIO-16E-1 DAQCard-6062E	8,192 samples
DAQPad-6020E	4,096 samples
6060E/6061E DAQPad-6070E DAQCard-6024E	2,048 samples
6041E	1,024 samples
PCI-MIO-16E-1 PXI-6070E 6071E, 6040E PCI-602xE PXI-6025E	512 samples

Data transfers

PCI, PXI, AT, DAQPad for IEEE 1394 ... DMA, interrupts, programmed I/O
DAQCard, DAQPad for USB Interrupts, programmed I/O

DMA modes

PCI, PXI, DAQPad for IEEE 1394 Scatter-gather (single-transfer, demand transfer)

AT Single transfer, demand transfer

Configuration memory size 512 words

Transfer Characteristics

Relative accuracy

Device	Typical Dithered	Maximum Undithered
607xE 606xE 604xE 6023E 6024E 6025E	±0.5 LSB	±1.5 LSB
6020E 6021E	±0.2 LSB	±1.5 LSB

DNL

Device	Typical	Maximum
607xE 6060E 6061E 604xE 6023E PCI-6024E 6025E	±0.5 LSB	±1.0 LSB
6020E 6021E	±0.2 LSB	±1.0 LSB
6062E DAQCard-6024E	±0.75 LSB	-0.9, +1.5 LSB

No missing codes 12 bits, guaranteed

E Series Multifunction DAQ Specifications

Specifications – 12-Bit E Series (NI 607xE, NI 606xE, NI 604xE, NI 602xE) (continued)

Amplifier Characteristics

Input impedance

Device	Normal Powered On	Powered Off	Overload
6070E 606xE 6040E PCI-6071E PXI-6071E	100 GΩ in parallel with 100 pF	820 Ω	820 Ω
6041E	100 GΩ in parallel with 100 pF	1 kΩ	1 kΩ
602xE	100 GΩ in parallel with 100 pF	4.7 kΩ	4.7 kΩ

Input bias current..... ±200 pA

Input offset current..... ±100 pA

CMRR, DC to 60 Hz

Device	Range	CMRR
607xE	20 V	95 dB
6060E	10 V	100 dB
6061E	100 mV to 5 V	106 dB
604xE	10 to 20 V	85 dB
6062E	5 V	95 dB
	100 mV to 2 V	100 dB
6023E	10 to 20 V	85 dB
6024E	100 mV to 1 V	90 dB
6025E		
6020E	100 mV to 20 V	90 dB
6021E		

Dynamic Characteristics

Bandwidth

Device	Small Signal (-3 dB)	Large Signal (1% THD)
607xE	1.6 MHz	1 MHz
6060E/6061E	1 MHz	300 kHz
6062E	1.3 MHz	250 kHz
6041E	800 kHz	400 kHz
6040E	600 kHz	350 kHz
6023E	500 kHz	225 kHz
PCI-6024E 6025E		
DAQCard-6024E	500 kHz	265 kHz
6021E	150 kHz	120 kHz

Settling time to full-scale step

Device	Range	Accuracy		
		±0.012% (±0.5 LSB)	±0.024% (±1 LSB)	±0.098% (±4 LSB)
6070E	20 V	2 μs typical 3 μs max	1.5 μs typical 2 μs max	1.5 μs typical 2 μs max
	10 V	2 μs typical 3 μs max	1.5 μs typical 2 μs max	1.3 μs typical 1.5 μs max
	200 mV to 5 V	2 μs typical 3 μs max	1.5 μs typical 2 μs max	0.9 μs typical 1 μs max
	100 mV	2 μs typical 3 μs max	1.5 μs typical 2 μs max	1 μs typical 1.5 μs max
PCI-6071E PXI-6071E	20 V	3 μs typical 5 μs max	1.9 μs typical 2.5 μs max	1.9 μs typical 2 μs max
	10 V	3 μs typical 5 μs max	1.9 μs typical 2.5 μs max	1.2 μs typical 1.5 μs max
	200 mV to 5 V	3 μs typical 5 μs max	1.9 μs typical 2.5 μs max	1.2 μs typical 1.3 μs max
	100 mV	3 μs typical 5 μs max	1.9 μs typical 2.5 μs max	1.2 μs typical 1.5 μs max
6060E	All	2 μs typical 4 μs max	1.9 μs typical 2 μs max	1.8 μs typical 2 μs max
6061E	All	5 μs max	3 μs max	2 μs max
6062E	All	2.5 μs typical 4 μs max	2.5 μs typical 3 μs max	2 μs typical 2.5 μs max
604xE	All	4 μs typical 8 μs max	4 μs max	4 μs max
6023E 6024E 6025E	All	5 μs typical	5 μs max	5 μs max
6020E 6021E	All	10 μs max	10 μs max	10 μs max

System noise (LSB_{rms}, not including quantization)

Device	Range	Dither Off	Dither On
6070E	1 to 20 V	0.25	0.5
PCI-6071E PXI-6071E	500 mV	0.4	0.6
	200 mV	0.5	0.7
	100 mV	0.8	0.9
6060E 6061E	200 mV	0.3	0.6
	100 mV	0.5	0.7
6062E	1 to 20 V	0.25	0.6
	500 mV	0.4	0.75
	200 mV	0.5	0.8
	100 mV	0.8	1.0
604xE	1 to 20 V	0.2	0.5
	500 mV	0.25	0.5
	200 mV	0.5	0.7
	100 mV	0.9	1.0
6023E	1 to 20 V	0.1	0.6
PCI-6024E, 6025E DAQCard-6024E	100 mV	0.7	0.8
	10 to 20 V	0.1	0.65
	1 V	0.45	0.65
	100 mV	0.70	0.90
6020E 6021E	1 to 20 V	0.07	0.5
	500 mV	0.12	0.5
	200 mV	0.25	0.6
	100 mV	0.5	0.7

Crosstalk, DC to 100 KHz

Device	Adjacent Channels	All Other Channels
607xE, 606xE, 604xE	-75 dB	-90 dB
602xE	-60 dB	-80 dB

E Series Multifunction DAQ Specifications

Specifications – 12-Bit E Series (NI 607xE, NI 606xE, NI 604xE, NI 602xE) (continued)

Analog Output

Output Characteristics

Number of channels

607xE 606xE 6040E 6020E 6021E 6024E 6025E	2 voltage outputs
6041E 6023E	None

Resolution 12 bits, 1 in 4,096
 Type of DAC Double buffered, multiplying
 Maximum update rate

Device	Waveform Generation			
	FIFO Mode		Non-FIFO Mode	
	Internally Timed	Externally Timed	1 Channel	2 Channels
607xE 6060E, 6061E 6040E	1 MS/s	950 kS/s	800 kS/s, system dependent	400 kS/s, system dependent
6062E	850 kS/s	850 kS/s	800 kS/s, system dependent	400 kS/s, system dependent
6023E PCI-6024E 6025E	N/A	N/A	10 kS/s with DMA 1 kS/s with interrupts system dependent	10 kS/s with DMA 1 kS/s with interrupts system dependent
DAQCard-6024E	N/A	N/A	1 kS/s with interrupts system dependent	1 kS/s with interrupts system dependent
6020E; except DAQPad-6020E	N/A	N/A	100 kS/s, system dependent	100 kS/s, system dependent
DAQPad-6020E	N/A	N/A	20 S/s, system dependent	20 S/s, system dependent

FIFO buffer size

607xE, 606xE	2,048 samples
6040E	512 samples
602xE	None

Data transfers

PCI, PXI, AT, DAQPad for IEEE 1394 ... DMA, interrupts, programmed I/O
 DAQCard, DAQPad for USB Interrupts, programmed I/O

DMA modes

PCI, PXI, DAQPad Scatter-gather (single transfer, demand transfer)
 AT Single transfer, demand transfer

Transfer Characteristics

Relative accuracy

After calibration
 6062E, DAQCard-6024E ±0.5 LSB typical, ±1.0 LSB max
 All others ±0.3 LSB typical, ±0.5 LSB max
 Before calibration ±4 LSB max

DNL

After calibration
 6062E, DAQCard-6024E ±0.5 LSB typical, ±1.0 LSB max
 All others ±0.3 LSB typical, ±1.0 LSB max
 Before calibration ±3 LSB max

Monotonicity 12 bits, guaranteed after calibration

Gain error (relative to external reference)

6062E ±0.5% of output max, not adjustable
 All others 0 to 0.67% of output max, not adjustable

Voltage Output

Ranges

607xE, 6060E 6061E, 6040E 6020E, 6021E	±10 V, 0 to 10 V, ±EXTREF, 0 to EXTREF; software selectable
6062E	±10 V, ±EXTREF, software selectable
6024E, 6025E	±10 V

Output coupling DC
 Output impedance 0.1 Ω max
 Current drive ±5 mA max
 Protection Short-circuit to ground
 Power-on state 0 V (±200 mV)

External reference input (not available on 6024E or 6025E)

Range ±11 V

Overvoltage protection

607xE	±25 V powered on, ±15 V powered off
606xE 604xE	
602xE	±35 V powered on, ±25 V powered off

Input impedance 10 kΩ

Bandwidth (-3 dB)

607xE 6060E, 6061E 604xE	1 MHz
6062E	50 kHz
602xE	300 kHz

Dynamic Characteristics

Settling time and slew rate

Device	Settling Time for Full-Scale Step	Slew Rate
607xE 606xE 6040E	3 μs to ±0.5 LSB accuracy	20 V/μs
602xE	10 μs to ±0.5 LSB accuracy	10 V/μs

Noise 200 μV_{rms}, DC to 1 MHz

Glitch energy (at mid-scale transition)

Magnitude

Device	Reglitching Disabled	Reglitching Enabled
DAQPad-6070E PCI-MIO-16E-1 PCI-6071E PXI-6070E PXI-6071E	±20 mV	±4 mV
AT-MIO-16E-1 6060E, 6061E 604xE	±200 mV	±30 mV
PCI-6024E 6025E	±42 mV	N/A
DAQCard-6024E	±13 mV	N/A
6020E 6021E	±100 mV	N/A
6062E	±80 mV	±30 mV

Duration

607xE 6060E, 6061E 604xE	1.5 μs
6024E 6025E	2 μs
6020E 6021E 6062E	3 μs

Stability

Gain temperature coefficient

External reference ±25 ppm/°C

Digital I/O

Number of channels

6021E 6025E	32 input/output
All others	8 input/output

E Series Multifunction DAQ Specifications

Specifications – 12-Bit E Series (NI 607xE, NI 606xE, NI 604xE, NI 602xE) (continued)

Compatibility 5 V/TTL
 Power-on state Input; high impedance
 Digital logic levels
 DIO<0..7> on all devices
 PA<0..7>, PB<0..7>, PC<0..7> on remaining 24 lines of 6021E and 6025E

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (I _{out} = 24 mA)	–	0.4 V
Output high voltage (I _{out} = 13 mA)	4.35 V	–

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (I _{out} = 2.5 mA)	–	0.4 V
Output high voltage (I _{out} = 2.5 mA)	3.9 V	–

Data transfers

6021E	Interrupts, programmed I/O
6025E	Programmed I/O
All others	Programmed I/O

Handshaking (6021E and 6025E only)

Direction Input or output
 Modes 2-wire

Transfer rate (1 word = 8 bits)

Maximum with NI-DAQ, system dependent

DAQPad-6070E	5 kwords/s
All others	50 kwords/s

Constant sustainable rate 1 to 10 kwords/s, typical

Timing I/O

General-Purpose Up/Down Counter/Timers

Number of channels 2
 Resolution 24 bits
 Compatibility 5 V/TTL

Digital logic levels

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (I _{out} = 5 mA)	–	0.4 V
Output high voltage (I _{out} = 3.5 mA)	4.35 V	–

Base clocks available 20 MHz and 100 kHz
 Base clock accuracy ±0.01%
 Maximum source frequency 20 MHz
 External source selections¹ PFI0..PFI9, RTSI0..RTSI6, analog trigger; software selectable
 External gate selections¹ PFI0..PFI9, RTSI0..RTSI6, analog trigger; software selectable
 Minimum source pulse duration 10 ns
 Minimum gate pulse duration 10 ns, edge-detect mode
 Data transfers
 PCI, PXI, AT, DAQPad for IEEE 1394 ... DMA, interrupts, programmed I/O
 DAQCard, DAQPad for USB Interrupts, programmed I/O
 DMA modes
 PCI, PXI, DAQPad for IEEE 1394 Scatter-gather (single transfer, demand transfer)
 AT Single transfer, demand transfer

Frequency Scaler

Number of channels 1
 Resolution 4 bits
 Compatibility 5 V/TTL
 Digital logic levels

Level	Minimum	Maximum
Input low voltage	0 V	0.8 V
Input high voltage	2 V	5 V
Output low voltage (I _{out} = 5 mA)	–	0.4 V
Output high voltage (I _{out} = 3.5 mA)	4.35 V	–

Base clocks available 10 MHz, 100 kHz
 Base clock accuracy ±0.01%
 Data transfers Programmed I/O

Triggers

Analog Triggers

Number of triggers

607xE	1
606xE	
604xE	
602xE	None

Purpose

Analog input Start and stop trigger, gate, clock
 Analog output Start trigger, gate, clock
 General-purpose counter/timers Source, gate

Source

6070E	ACH<0..15>, PFI0/TRIG1
6062E, 6060E	
604xE, 602xE	
6071E	ACH<0..63>, PFI0/TRIG1
6061E	

Level

Internal source, ACH<0..15/63> ±Full-scale
 External source, PFI0/TRIG1 ±10 V

Slope Positive or negative; software selectable

Resolution 8 bits, 1 in 256

Bandwidth (-3 dB)

Device	Internal Source	External Source
607xE	2 MHz	7 MHz
6060E, 6061E	1 MHz	7 MHz
6062E	500 kHz	2.5 MHz
604xE	2 MHz	3 MHz

Hysteresis Programmable
 Accuracy ±5% of full-scale range max

Digital Triggers (all devices)

Number of triggers 2

Purpose

Analog input Start and stop trigger, gate, clock
 Analog output Start trigger, gate, clock
 General-purpose counter/timers Source, gate

Source¹ PFI0..PFI9, RTSI0..RTSI6

Slope Positive or negative; software selectable

Compatibility 5 V/TTL

Response Rising or falling edge

Pulse width 10 ns minimum

External input for digital or analog trigger... (PFI0/TRIG1)

Impedance

6062E 12 kΩ
 All others 10 kΩ

Coupling DC

Protection

Digital trigger -0.5 to V_{cc} + 0.5 V
 Analog trigger
 On/off/disabled ±35 V

Calibration

Recommended warm-up time 15 minutes; 30 minutes for DAQCard and DAQPad

Calibration interval 1 year

Onboard calibration reference

DC level 5.000 V (±3.5 mV) over full operating temperature, actual value stored in EEPROM

Temperature coefficient ±5 ppm/°C max

Long-term stability ±15 ppm/√1000 h

E Series Multifunction DAQ Specifications

Specifications – 12-Bit E Series (NI 607xE, NI 606xE, NI 604xE, NI 602xE) (continued)

RTSI (PCI, IEEE 1394, and ISA only)

Trigger lines ¹	
PCI, ISA	7
DAQPad for IEEE 1394	4

PXI Trigger Bus (PXI only)

Trigger lines.....	6
Star trigger.....	1

Bus Interface

PCI, PXI, DAQPad for IEEE 1394.....	Master, slave
AT, DAQCard, DAQPad for USB.....	Slave

Power Requirements²

Device	+5 VDC (±5%)*	Power Available at I/O Connector
607xE	1.1 A	+4.65 to +5.25 VDC, 1 A
6060E, 6061E 6040E	1.0 A	+4.65 to +5.25 VDC, 1 A
602xE, (except DAQPad and DAQCard)	0.7 A	+4.65 to +5.25 VDC, 1 A
DAQCard-6062E	340 mA typical 750 mA maximum	+4.65 to +5.25 VDC, 250 mA
DAQCard-6024E	270 mA typical 750 mA maximum	+4.65 to +5.25 VDC, 250 mA
DAQCard-AI-16E-4	280 mA typical 400 mA maximum	+4.65 to +5.25 VDC, 250 mA

Device	Power	Power Available at I/O Connector
DAQPad-6020E	15 W +9 to +30 VDC	+4.65 to +5.25 VDC, 1 A
DAQPad-6070E	17 W +9 to +25 VDC	+4.65 to +5.25 VDC, 1 A

Discharge time with BP-1 battery pack

*Excludes power consumed through I/O connector.

IEEE 1394 DAQPad	2.5 hours, typical
USB DAQPad	3 hours, typical

Physical²

Dimensions (not including connectors)

PCI	17.5 by 9.9 cm (6.9 by 3.9 in.)
PXI.....	16.0 by 10.0 cm (6.3 by 3.9 in.)

ISA (long)	33.8 by 9.9 cm (13.3 by 3.9 in.)
ISA (short)	17.5 by 9.9 cm (6.9 by 4.2 in.)
DAQPad (30 cm enclosure)	25.4 by 30.5 by 4.6 cm (10 by 12 by 1.8 in.)
DAQPad (15 cm enclosure)	14.6 by 21.3 by 3.8 cm (5.8 by 8.4 by 1.5 in.)
DAQCard	Type II PC Card

I/O Connector

6070E 6060E 6040E 6020E 6023E PCI-6024E	68-pin male 0.050 D-type
DAQCard-6062E, DAQCard-6024E	68-pin female VHDCI
6071E 6061E 6021E 6025E	100-pin female 0.050 D-type
DAQCard-AI-16E-4	68-pin female PCMCIA

Environment

Operating temperature	0 to 55 °C; 0 to 40 °C for DAQCard-6062E and DAQCard-6024E with a maximum internal temperature of 70 °C as measured by onboard temperature sensor; case temperature should not exceed 55 °C for any DAQCard
Storage temperature.....	-20 to 70 °C
Relative humidity	10 to 90%, noncondensing

Certifications and Compliances

CE Mark Compliance

¹Refer to RTSI specifications for available RTSI trigger lines.

²See page 148 for RT Series devices, power requirements and physical parameters.

E Series DAQ Accuracy Specifications



Every Measurement Counts

There is no room for error in your measurements. From sensor to software, your system must deliver accurate results. NI provides detailed specifications for our products so that you do not have to guess how they will perform. Along with traditional data acquisition specifications, our E Series multifunction data acquisition (DAQ) devices also include accuracy tables to assist you in selecting the appropriate hardware for your application. These tables are found on the product pages and include specifications for both absolute and relative accuracy.

Absolute Accuracy

Absolute accuracy is the specification you use to determine the overall maximum error of your measurement. Absolute accuracy specifications apply only to a successfully calibrated DAQ device. There are four components of an absolute accuracy specification:

Percent of Reading is a percent of the actual input voltage.

Offset is a constant offset applied to all measurements.

Noise + Quantization is based on noise and depends on the number of points averaged for each measurement.

Drift is based on variations in your ambient temperature.

Based on these components, the formula for calculating absolute accuracy is:

$$\text{Absolute Accuracy} = \pm[(\text{Input Voltage} \times \% \text{ of Reading}) + (\text{Offset} + \text{Noise} + \text{Quantization} + \text{Drift})]$$

Drift is already accounted for unless your ambient temperature is outside +15 to +35 °C. For instance, if your ambient temperature is at 45 °C, you must account for 10 °C of drift. This is calculated by:

$$\text{Drift} = \text{Temperature Difference} \times \% \text{ Drift per } ^\circ\text{C} \times \text{Input Voltage}$$

Absolute Accuracy at Full Scale is a calculation of absolute accuracy for a specific voltage range using the maximum voltage within that range taken one year after calibration, the Accuracy Drift Reading, and the Noise + Quantization averaged value.

Below is the **Absolute Accuracy at Full Scale** calculation for the PCI-MIO-16XE-50 after one year using the ± 10 V input range while averaging 100 samples of a 10 V input signal. In all the Absolute Accuracy at Full Scale calculations, we assume that the ambient temperature is between 15 and 35 °C. You can see on the next page that the calculation for the ± 10 V input range for Absolute Accuracy at Full Scale yields 1.443 mV. This calculation is done using the parameters in the same row for one year Absolute Accuracy Reading, Offset and Noise + Quantization as well as a value of 10 V for the input voltage value. You can then see that the calculation is as follows:

$$\text{Absolute Accuracy} = \pm[(10 \times 0.0001) + 397.2 \mu\text{V} + 45.8 \mu\text{V}] = \pm 1.443 \text{ mV}$$

The following example assumes the same conditions except that the ambient temperature is 45 °C. You can begin with the calculation above and add in the Drift calculation using the % Drift per °C from the table on the next page (see Table 1).

$$\text{Absolute Accuracy} = 1.443 \text{ mV} + ((45 ^\circ\text{C} - 35 ^\circ\text{C}) \times 0.000002 / ^\circ\text{C} \times 10 \text{ V}) = \pm 1.643 \text{ mV}$$

If you are making single-point measurements, use the Single-Point Noise + Quantization specification from the accuracy tables. If you are averaging multiple points for each measurement, the value for Noise + Quantization changes. The Averaged Noise + Quantization in the accuracy tables assumes that you average 100 points per measurement. If you are averaging a different number of points, use the following equation to determine your Noise + Quantization:

$$\text{Noise} + \text{Quantization for } x \text{ averaged points} = \frac{\text{Averaged Noise} + \text{Quantization from table} \times \sqrt{100/X}}$$

For example, if you are averaging 1000 points per measurement with the PCI-MIO-16XE-50 in the ± 10 V input range, the Noise + Quantization is determined by:

$$\text{Noise} + \text{Quantization} = 45.7 \mu\text{V} \times \sqrt{100/1000} = 14.5 \mu\text{V}$$

The Noise + Quantization specifications assume that dithering is disabled for single-point measurements and enabled for averaged measurements.

See page 24 or visit ni.com/calibration for more information on the importance of calibration on DAQ device accuracy.

To calculate the accuracy of NI measurement products, visit ni.com/measurements/accuracy

E Series DAQ Accuracy Specifications

Relative Accuracy

Relative accuracy is the specification that compares the difference between two or more measurements. It indicates the degree to which two or more measurements can be distinguished from each other. The two major contributors to relative accuracy are the resolution of the device's analog-to-digital Converter (ADC) and the system noise. The accuracy tables show both single-point and averaged relative accuracy, which include both ADC resolution and system noise effects. Averaging will improve your relative accuracy for DC measurements.

As an example, assume you are monitoring a voltage once per second using the ± 10 V range on the PCI-MIO-16XE-50 and averaging 100 points for each measurement. Using the accuracy table on page 255 (reprinted below for your convenience), we find:

$$\text{Averaged Relative Accuracy} = 60.3 \mu\text{V}$$

This means that a measurement taken at time t_2 would have to be 60.3 μV greater or less than the measurement taken at time t_1 in order to detect a difference in the input voltage. Relative accuracy does not depend on DAQ device calibration.

Detailed Specifications

The pages starting at page 266 contain detailed specifications for all National Instruments E Series multifunction devices. Devices can be identified by their family number. For instance, if you want to determine the common-mode rejection ratio (CMRR) in the 10 V range for the PCI-6052E in unipolar range, you would look at the 16-bit E Series Multifunction DAQ specification on page 272. For the 10 V range, the CMRR specification for the NI 6052E devices is 97 dB.

	Nominal Range (V)	Absolute Accuracy							Relative Accuracy		
		% of Reading			Offset (μV)	Noise + Quantization (μV)		Temp Drift (%/ $^{\circ}\text{C}$)	Absolute Accuracy at Full Scale (mV)	Resolution (μV)	
		24 Hrs	90 Days	1 Year		Single Pt.	Averaged			Single Pt.	Averaged
PCI, AT, and DAQPad	± 10	0.0058%	0.0078%	0.0100%	397.2	526.4	45.8	0.0002	1.443	602.7	60.3
	± 5	0.0208%	0.0228%	0.0250%	200.6	263.2	22.9	0.0007	1.474	301.4	30.1
	± 1	0.0208%	0.0228%	0.0250%	43.3	52.6	4.6	0.0007	0.298	60.3	6.0
	± 0.1	0.0408%	0.0428%	0.0450%	7.9	8.4	0.7	0.0012	0.054	9.6	1.0
	0 to 10	0.0058%	0.0078%	0.0100%	244.6	263.2	22.9	0.0002	1.268	301.4	30.1
	0 to 5	0.0208%	0.0228%	0.0250%	124.3	131.6	11.4	0.0007	1.386	150.7	15.1
	0 to 1	0.0208%	0.0228%	0.0250%	28.1	26.3	2.3	0.0007	0.280	30.1	3.0
	0 to 0.1	0.0408%	0.0428%	0.0450%	6.4	7.0	0.6	0.0012	0.052	8.4	0.8
DAQCard	± 10	0.0075%	0.0095%	0.0117%	815.4	1029.1	91.6	0.0005	2.077	1205.4	120.5
	± 5	0.0225%	0.0245%	0.0267%	409.7	514.6	45.8	0.0010	1.791	602.7	60.3
	± 1	0.0225%	0.0245%	0.0267%	85.1	102.9	9.2	0.0010	0.361	120.5	12.1
	± 0.1	0.0425%	0.0445%	0.0467%	12.1	12.2	1.1	0.0015	0.060	14.5	1.4
	0 to 10	0.0075%	0.0095%	0.0117%	591.2	514.6	45.8	0.0005	1.807	602.7	60.3
	0 to 5	0.0225%	0.0245%	0.0267%	297.6	257.3	22.9	0.0010	1.656	301.4	30.1
	0 to 1	0.0225%	0.0245%	0.0267%	62.7	51.5	4.6	0.0010	0.334	60.3	6.0
	0 to 0.1	0.0425%	0.0445%	0.0467%	9.9	8.0	0.7	0.0015	0.057	9.6	1.0

Note: Accuracies are valid for measurements following an internal E Series Calibration. Averaged numbers assume dithering and averaging of 100 single-channel readings. Measurement accuracies are listed for operational temperatures within ± 1 $^{\circ}\text{C}$ of internal calibration temperature and ± 10 $^{\circ}\text{C}$ of external or factory-calibration temperature. One-year calibration interval recommended. The Absolute Accuracy at Full Scale calculations were performed for a maximum range input voltage (for example, 10 V for the ± 10 V range) after one year, assuming 100 pt averaging of data. See Overview on page 234 for an example calculation of this type.

Table 1. NI 601xE Analog Input Accuracy Specifications